

An updated model of Rietveld structure refinement of Na/K-feldspar

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List of abbreviations used in this paper:

XRPD: X-ray powder diffraction

SC-XRD: single-crystal X-ray diffraction.

BB-XRPD: Bragg-Brentano XRPD

ALBITE: Albite sample from Jiaodong peninsula, Shandong Province, China.

PERTHITE: a perthite sample from Bayan Obo, Inner Mongolia, China.

GSAS: Rietveld refinement by General Structure Analysis System.

SDC: a soft distance constraint for Al/Si-O bond lengths.

T-O: Al/Si-O bond length.

Albite-N: a model that did not apply SDCs during refining of the albite sample.

Albite: a model that applied SDCs during refining of the albite sample.

R-LPA: average value of lattice parameters of albite from the references.

R-BLA: average value of T-O bond lengths in one tetrahedron of albite from the references.

R-MAA: mean of six O-T-O angles in one tetrahedron of albite from the references

R-LPM: average value of lattice parameters of microcline from the references.

R-BLM: average value of T-O bond lengths in one tetrahedron of microcline from the references.

R-MAM: mean of six O-T-O angles in one tetrahedron of microcline from the references.

PERTHITE-a: the albite phase in the perthite sample.

PERTHITE-m: the microcline phase in the perthite sample.

Table S1. Structure parameters of albite in the ALBITE sample.

Atom type	<i>x</i>	<i>y</i>	<i>z</i>	O _{cc}	U _{iso}
Na	0.2754(5)	0.98926(24)	0.15465(6)	1.00	0.0688(9)
T _{1o}	0.0110(5)	0.16752(24)	0.20811(6)	1.00/0.00 ^a	0.0204(9)
T _{1m}	0.0063(5)	0.81852(24)	0.23752(6)	0.00/1.00	0.0198(9)
T _{2o}	0.6941(5)	0.10852(24)	0.31482(6)	0.00/1.00	0.0202(9)
T _{2m}	0.6835(5)	0.88032(24)	0.36042(6)	0.00/1.00	0.0199(9)
O _{A1}	0.0077(5)	0.12901(24)	0.96608(6)	1.00	0.0105(9)
O _{A2}	0.5951(5)	0.99561(24)	0.28048(6)	1.00	0.0077(9)
O _{Bo}	0.8146(5)	0.10831(24)	0.19018(6)	1.00	0.0113(9)
O _{Bm}	0.8222(5)	0.84941(24)	0.25838(6)	1.00	0.0138(9)
O _{Co}	0.0154(5)	0.30171(24)	0.26868(6)	1.00	0.0100(9)
O _{Cm}	0.0261(5)	0.69171(24)	0.22878(6)	1.00	0.0102(9)
O _{Do}	0.2097(5)	0.10731(24)	0.38868(6)	1.00	0.0105(9)
O _{Dm}	0.1862(5)	0.86631(24)	0.43448(6)	1.00	0.0124(9)

Note: Estimated standard deviations, given in parentheses, refer to the last decimal place.

a. Al/Si site occupancies.

Table S2. Structure parameters of albite in the PERTHITE sample.

Atom type	<i>x</i>	<i>y</i>	<i>z</i>	O _{cc}	U _{iso}
Na	0.3400(10)	0.9773(7)	0.14685(15)	1.00	0.1059(34)
T _{1o}	0.0057(10)	0.1709(7)	0.20851(15)	1.00/0.00 ^a	0.0460(34)
T _{1m}	0.0010(10)	0.8219(7)	0.23791(15)	0.00/1.00	0.0418(34)
T _{2o}	0.6888(10)	0.1119(7)	0.31521(15)	0.00/1.00	0.0419(34)
T _{2m}	0.6782(10)	0.8837(7)	0.36081(15)	0.00/1.00	0.0425(34)
O _{A1}	0.0025(10)	0.1324(7)	0.96657(15)	1.00	0.0576(34)
O _{A2}	0.5899(10)	0.9990(7)	0.28097(15)	1.00	0.0472(34)
O _{Bo}	0.8094(10)	0.1117(7)	0.19067(15)	1.00	0.0574(34)
O _{Bm}	0.8170(10)	0.8528(7)	0.25887(15)	1.00	0.0670(34)
O _{Co}	0.0102(10)	0.3051(7)	0.26917(15)	1.00	0.0531(34)
O _{Cm}	0.0209(10)	0.6951(7)	0.22927(15)	1.00	0.0483(34)
O _{Do}	0.2045(10)	0.1107(7)	0.38917(15)	1.00	0.0475(34)
O _{Dm}	0.1810(10)	0.8697(7)	0.43497(15)	1.00	0.0623(34)

Note: Estimated standard deviations, given in parentheses, refer to the last decimal place.

a. Al/Si site occupancies.

Table S3. Structure parameters of microcline in the PERTHITE sample.

Atom type	<i>x</i>	<i>y</i>	<i>Z</i>	O _{cc}	U _{iso}
K	0.28332(35)	0.99806(30)	0.14688(7)	1.00	0.0362(8)
T _{1o}	0.00899(35)	0.18666(30)	0.21789(7)	0.96/0.04 ^a	0.0222(8)

T _{1m}	0.00856(35)	0.81906(30)	0.23200(7)	0.02/0.98	0.0219(8)
T _{2o}	0.70917(35)	0.11954(30)	0.34078(7)	0.01/0.99	0.0226(8)
T _{2m}	0.70415(35)	0.88488(30)	0.35040(7)	0.01/0.99	0.0140(8)
O _{A1}	0.99983(35)	0.14387(30)	0.98408(7)	1.00	0.0341(8)
O _{A2}	0.63394(35)	0.00437(30)	0.28637(7)	1.00	0.0330(8)
O _{B0}	0.82034(35)	0.14607(30)	0.22038(7)	1.00	0.0369(8)
O _{Bm}	0.83024(35)	0.85687(30)	0.23978(7)	1.00	0.0379(8)
O _{C0}	0.03353(35)	0.31817(30)	0.25247(7)	1.00	0.0325(8)
O _{Cm}	0.03653(35)	0.69467(30)	0.26917(7)	1.00	0.0307(8)
O _{D0}	0.18944(35)	0.12277(30)	0.40518(7)	1.00	0.0322(8)
O _{Dm}	0.17573(35)	0.87387(30)	0.41148(7)	1.00	0.0326(8)

Note: Estimated standard deviations, given in parentheses, refer to the last decimal place.

a. Al/Si site occupancies.

Figure S1. Representation of a four-tetrahedron ring in monoclinic and triclinic alkali feldspar structures.

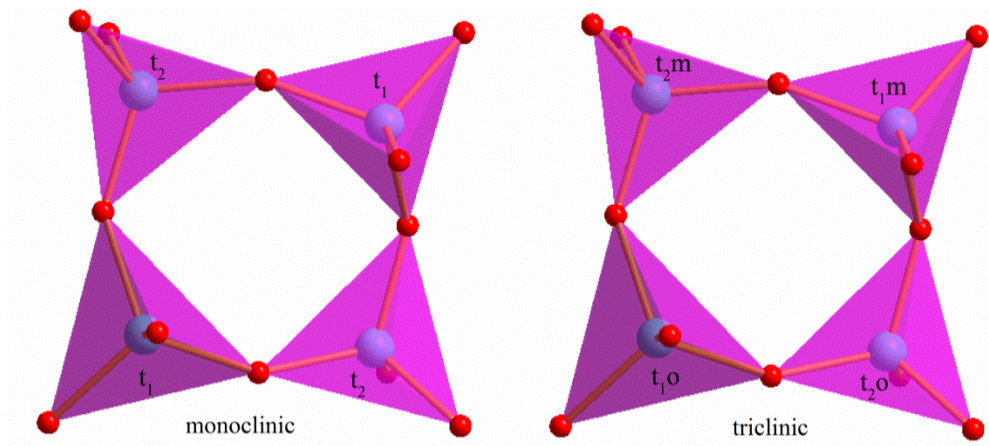


Fig. S2 Plots of Al/Si–O bond length vs. Al/(Al+Si) ratio for albite and microcline in published papers.

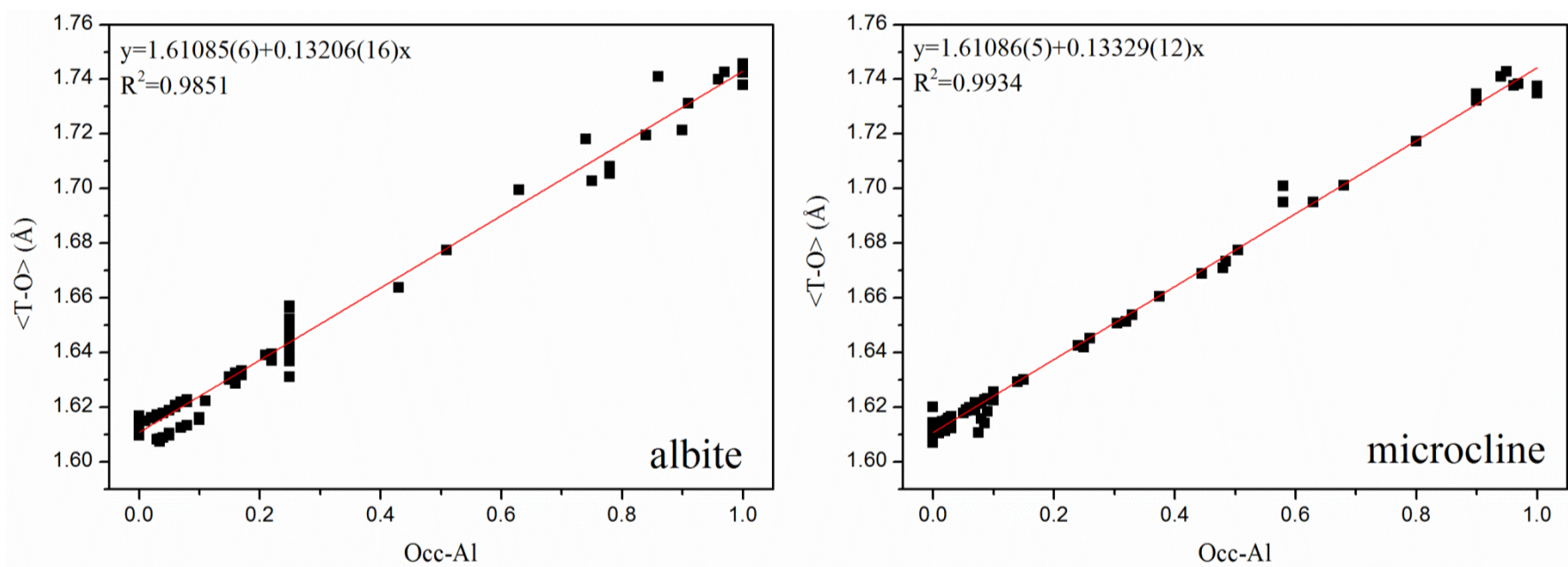


Figure S3. T–O distances in four tetrahedrons of albite in the PERTHITE sample (PERTHITE–a) and those from the albite references (R-BLA). M

denotes the mean for PERTHITE–a, R-BLA, and calculated value from Equation (1); ● PERTHITE–a; ▲ R-BLA; ▼ Calculated. The vertical bars represent errors. If no bar is given, then the error is contained within the area of the symbol.

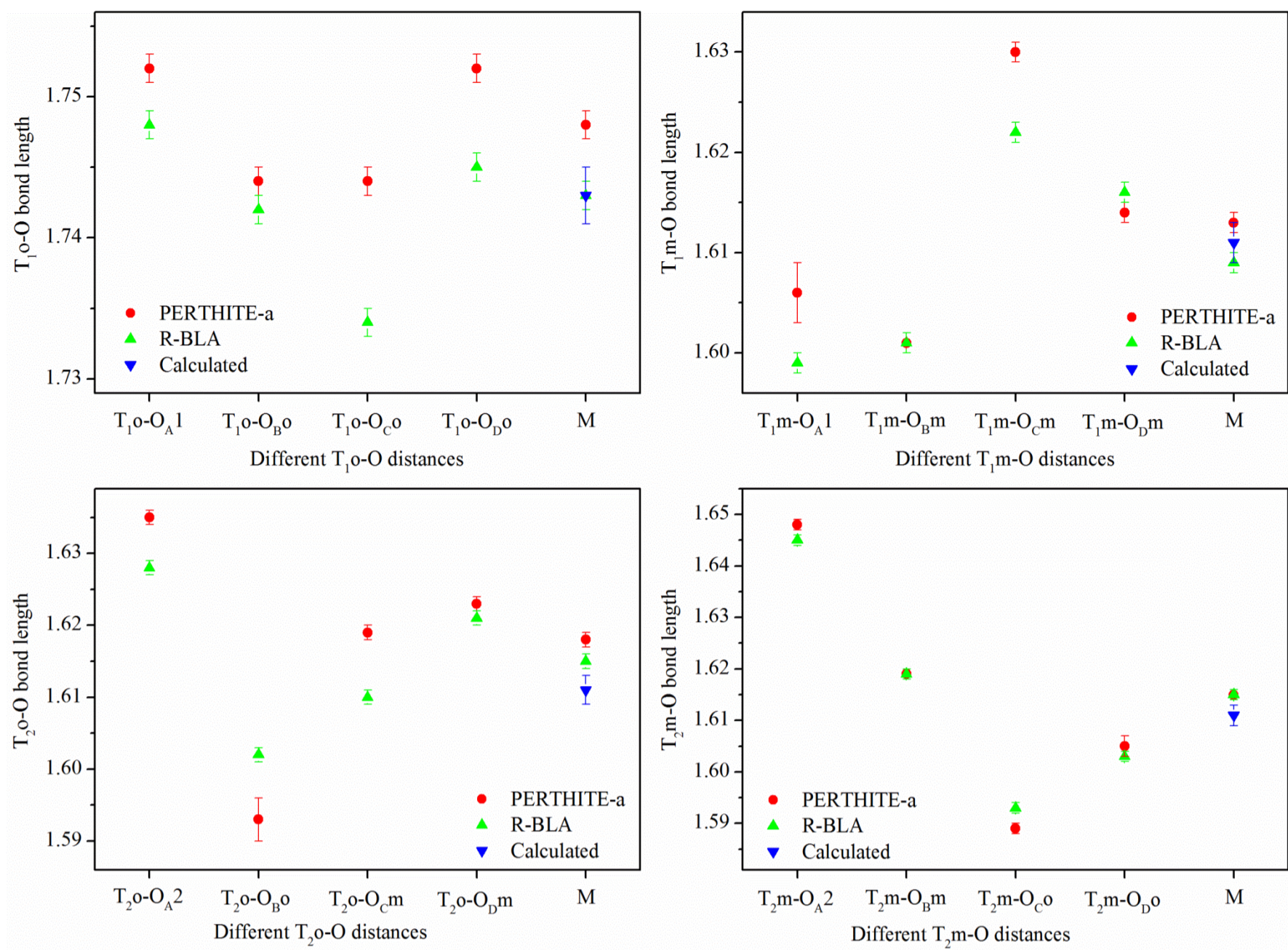


Figure S4. T-O distances in four tetrahedrons of microcline in the PERTHITE sample (PERTHITE-m) and those from the microcline references

(R-BLM). M denotes the mean for PERTHITE-m, R-BLM, and calculated value from the equation (2); ●PERTHITE-m; ▲R-BLM; ▼Calculated.

The vertical bars represent errors. If no bar is given, then the error is contained within the area of the symbol.

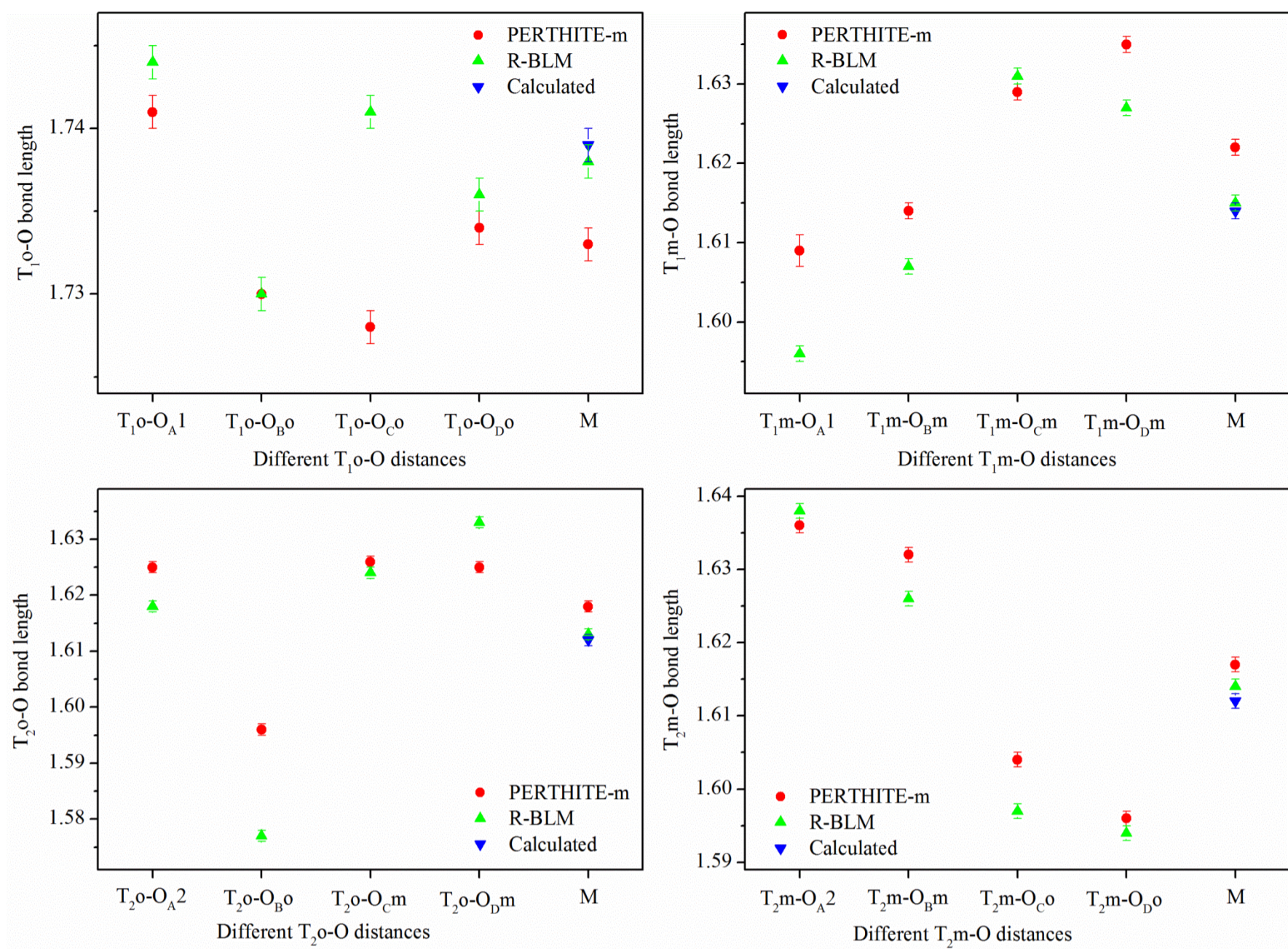


Figure S5. O-T-O angles in four tetrahedrons of albite from the albite references (R-MAA), the model Albite, the model Albite-N, and albite in PERTHITE sample (PERTHITE-a). M denotes the mean for R-MAA, Albite, Albite-N, and PERTHITE-a; ■R-MAA; ●Albite; ▲Albite-N; ▼PERTHITE-a. The vertical bars represent errors. If no bar is given, then the error is contained within the area of the symbol.

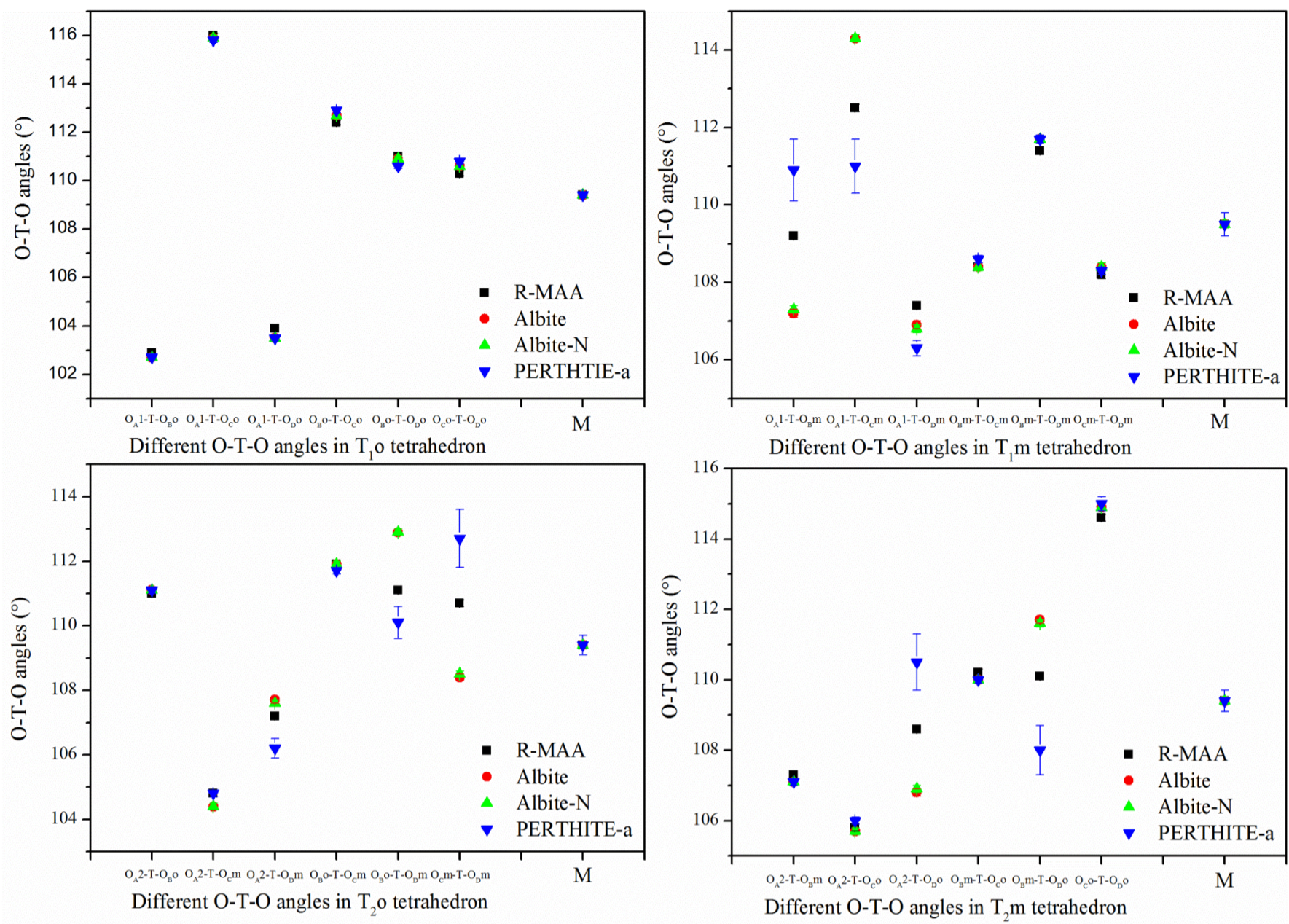


Figure S6. O-T-O angles in four tetrahedrons of microcline from the microcline references (R-MAM) and microcline in PERTHITE sample

(PERTHITE-m). M denotes the mean for R-MAM and PERTHITE-m; ■ R-MAM; ● PERTHITE-m. The vertical bars represent errors. If no bar is given, then the error is contained within the area of the symbol.

